

<b>Notice of References Cited</b>	Application/Control No. 10/767,875		Applicant(s)/Patent Under Reexamination KIM ET AL.	
	Examiner KEITH WALKER		Art Unit 1795	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,753,387	05-1998	Takami et al.	429/332
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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*	N	JP 2001023630 A	01-2001	Japan	HIRATA et al.	
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#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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